INTEGRATED CIRCUITS



Product specification Supersedes data of 1997 Aug 11 IC24 Data Handbook 1998 Apr 28



PHILIPS

Philips Semiconductors

74LVC00A

FEATURES

- Wide supply range of 1.2V to 3.6V
- Complies with JEDEC standard no. 8-1A
- Inputs accept voltages up to 5.5V
- CMOS low power consumption
- Direct interface with TTL levels
- 5-volt tolerant inputs, for interfacing with 5-volt logic

DESCRIPTION

The 74LVC00A is a high-performance, low power, low-voltage, Si-gate CMOS device and superior to most advanced CMOS compatible TTL families.

Inputs can be driven from either 3.3 V or 5 V devices. This feature allows the use of these devices as translators in a mixed 3.3 V/5 V environment.

Schmitt-trigger action at all inputs makes the circuit tolerant for slower input rise and fall times.

The 74LVC00A provides the 2-input NAND function.

QUICK REFERENCE DATA

GND = 0 V; $T_{amb} = 25^{\circ}C$; $t_r = t_f \le 2.5 \text{ ns}$

SYMBOL	PARAMETER	CONDITIONS	TYPICAL	UNIT
t _{PHL} t _{PLH}	Propagation delay nA, nB to nY	$\begin{array}{l} C_L = 50 \text{ pF}; \\ V_{CC} = 3.3 \text{ V} \end{array}$	3.0	ns
Cl	Input capacitance		5.0	pF
C _{PD}	Power dissipation capacitance per gate	$V_I = GND$ to V_{CC}^1	28	pF

NOTES:

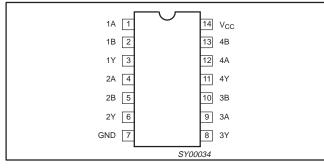
 C_{PD} is used to determine the dynamic power dissipation (P_D in μ W) $P_D = C_{PD} \times V_{CC}^2 x f_i + \sum (C_L \times V_{CC}^2 \times f_o)$ where: f_i = input frequency in MHz; C_L = output load capacity in pF; f_o = output frequency in MHz; V_{CC} = supply voltage in V; 1.

 $\sum (C_L \times V_{CC}^2 \times f_0)$ = sum of the outputs.

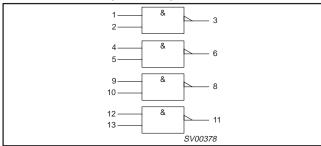
ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	DWG NUMBER
14-Pin Plastic SO	-40°C to +85°C	74LVC00A D	74LVC00A D	SOT108-1
14-Pin Plastic SSOP Type II	-40°C to +85°C	74LVC00A DB	74LVC00A DB	SOT337-1
14-Pin Plastic TSSOP Type I	-40°C to +85°C	74LVC00A PW	74LVC00APW DH	SOT402-1

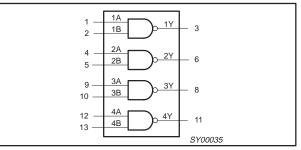
PIN CONFIGURATION



LOGIC SYMBOL (IEEE/IEC)



LOGIC SYMBOL

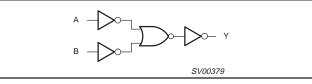


PIN DESCRIPTION

PIN NUMBER	SYMBOL	NAME AND FUNCTION
1, 4, 9, 12	1A – 4A	· Data inputs
2, 5, 10, 13	1B – 4B	Data inputs
3, 6, 8, 11	1Y – 4Y	Data outputs
7	GND	Ground (0 V)
14	V _{CC}	Positive supply voltage

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LOGIC DIAGRAM (ONE GATE)



FUNCTION TABLE

INP	OUTPUTS	
nA	nB	nY
L	L	Н
L	н	Н
н	L	Н
н	н	L

NOTES:

H = HIGH voltage level

L = LOW voltage level

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	CONDITIONS	LIM	UNIT	
STWBOL	PARAIVIETER	CONDITIONS	MIN	MAX	UNIT
V _{CC}	DC supply voltage (for max. speed performance)		2.7	3.6	V
V _{CC}	DC supply voltage (for low-voltage applications)		1.2	3.6	V
VI	DC Input voltage range		0	5.5	V
Vo	DC output voltage range		0	V _{CC}	V
T _{amb}	Operating ambient temperature range in free-air		-40	+85	°C
t _r , t _f	Input rise and fall times	$V_{CC} = 1.2 \text{ to } 2.7 \text{V}$ $V_{CC} = 2.7 \text{ to } 3.6 \text{V}$	0 0	20 10	ns/V

ABSOLUTE MAXIMUM RATINGS¹

Absolute Maximum Rating System (IEC 134) Voltages are referenced to GND (ground = 0V)

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V _{CC}	DC supply voltage (for max. speed performance)		-0.5 to +6.5	V
I _{IK}	DC input diode current	V ₁ <0	-50	mA
VI	DC input voltage	Note 2	-0.5 to +5.5	V
I _{OK}	DC output diode current	$V_{O} > V_{CC} \text{ or } V_{O} < 0$	±50	mA
V _O	DC output voltage	Note 2	-0.5 to V _{CC} + 0.5	V
Ι _Ο	DC output source or sink current	$V_{O} = 0$ to V_{CC}	±50	mA
I _{GND} , I _{CC}	DC V _{CC} or GND current		±100	mA
T _{stg}	Storage temperature range		-65 to +150	°C
P _{TOT}	Power dissipation per package – plastic mini-pack (SO) – plastic shrink mini-pack (SSOP and TSSOP)	above +70°C derate linearly with 8 mW/K above +60°C derate linearly with 5.5 mW/K	500 500	mW

NOTES:

1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

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DC CHARACTERISTICS

Over recommended operating conditions voltages are referenced to GND (ground = 0V)

			L	LIMITS Temp = -40°C to +85°C			
SYMBOL	PARAMETER	TEST CONDITIONS	Temp = -				
			MIN	TYP ¹	МАХ	1	
Maria		$V_{CC} = 1.2V$	V _{CC}			v	
VIH	V _{IH} HIGH level Input voltage	V _{CC} = 2.7 to 3.6V	2.0] `	
M		$V_{CC} = 1.2V$			GND	v	
V _{IL}	LOW level Input voltage	V _{CC} = 2.7 to 3.6V			0.8] `	
	HIGH level output voltage	$V_{CC} = 2.7V; V_I = V_{IH} \text{ or } V_{IL}; I_O = -12mA$	V _{CC} -0.5				
M		$V_{CC} = 3.0V; V_I = V_{IH} \text{ or } V_{IL}; I_O = -100 \mu A$	V _{CC} -0.2	V _{CC}		v	
V _{OH}		$V_{CC} = 3.0V; V_I = V_{IH} \text{ or } V_{IL;} I_O = -18\text{mA}$	V _{CC} -0.6] `	
		$V_{CC} = 3.0V; V_I = V_{IH} \text{ or } V_{IL;} I_O = -24\text{mA}$	V _{CC} -0.8			1	
		$V_{CC} = 2.7V; V_I = V_{IH} \text{ or } V_{IL}; I_O = 12mA$			0.40		
V _{OL}	LOW level output voltage	$V_{CC} = 3.0V; V_I = V_{IH} \text{ or } V_{IL}; I_O = 100 \mu A$			0.20	V	
		$V_{CC} = 3.0V; V_I = V_{IH} \text{ or } V_{IL;} I_O = 24\text{mA}$			0.55	1	
t	Input leakage current	$V_{CC} = 3.6V$; $V_I = 5.5V$ or GND		±0.1	±5	μΑ	
I _{CC}	Quiescent supply current	$V_{CC} = 3.6V; V_I = V_{CC} \text{ or GND}; I_O = 0$		0.1	10	μA	
ΔI_{CC}	Additional quiescent supply current per input pin			500	μΑ		

NOTES:

1. All typical values are at V_{CC} = 3.3V and T_{amb} = 25°C.

AC CHARACTERISTICS

GND = 0 V; $t_r = t_f \le 2.5 \text{ ns}$; $C_L = 50 \text{ pF}$

				LIMITS						
SYMBOL	PARAMETER	WAVEFORM	V _{CC}	; = 3.3V ±0).3V	\	/ _{CC} = 2.7\	/	V _{CC} = 1.2V	UNIT
			MIN	TYP ¹	MAX	MIN	TYP	MAX	TYP	
t _{PHL} / t _{PLH}	Propagation delay nA, nB to nY	1, 2	1.5	3.0	5.0	1.5	3.4	5.8	11	ns

NOTE:

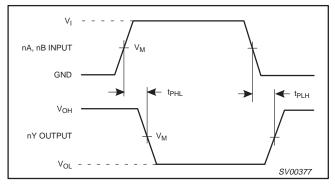
1. These typical values are at V_{CC} = 3.3V and T_{amb} = 25°C.

AC WAVEFORMS

 V_{M} = 1.5 V at $V_{CC}\,\geq\,2.7$ V

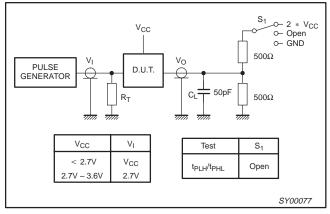
 $V_{\textrm{M}}$ = 0.5 • $V_{\textrm{CC}}$ at $V_{\textrm{CC}}$ < 2.7 V

 $V_{\mbox{OL}}$ and $V_{\mbox{OH}}$ are the typical output voltage drop that occur with the output load.



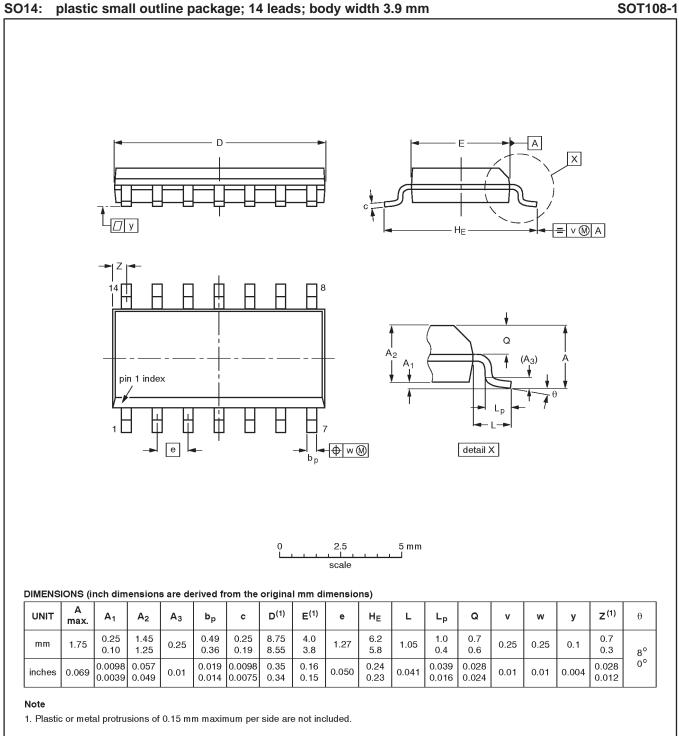
Waveform 1. Input (nA) to output (nY) propagation delays.

TEST CIRCUIT



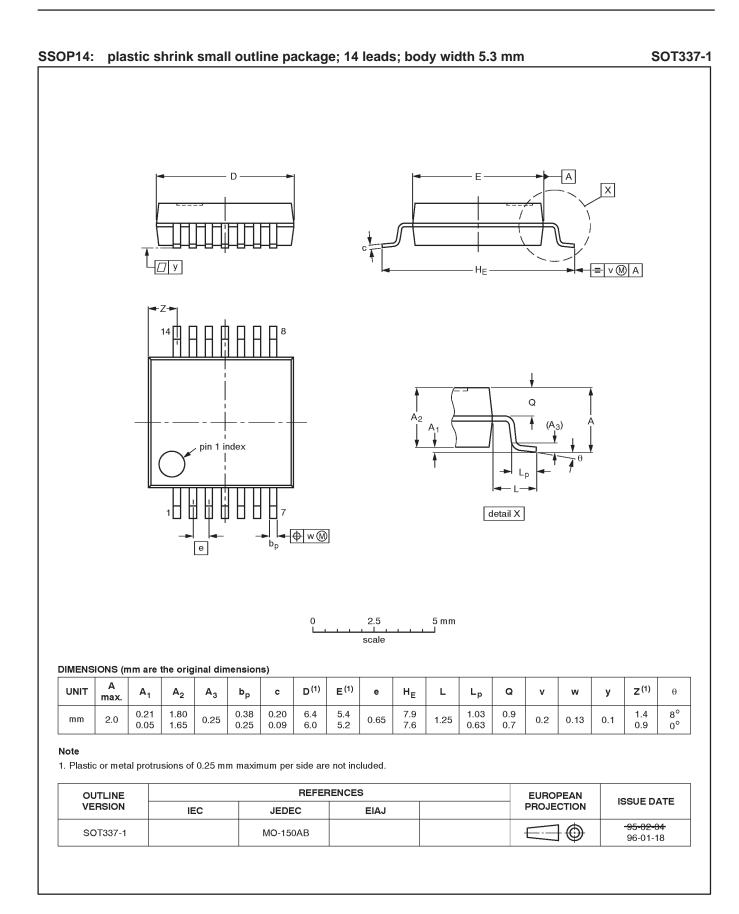
Waveform 2. Load circuitry for switching times.

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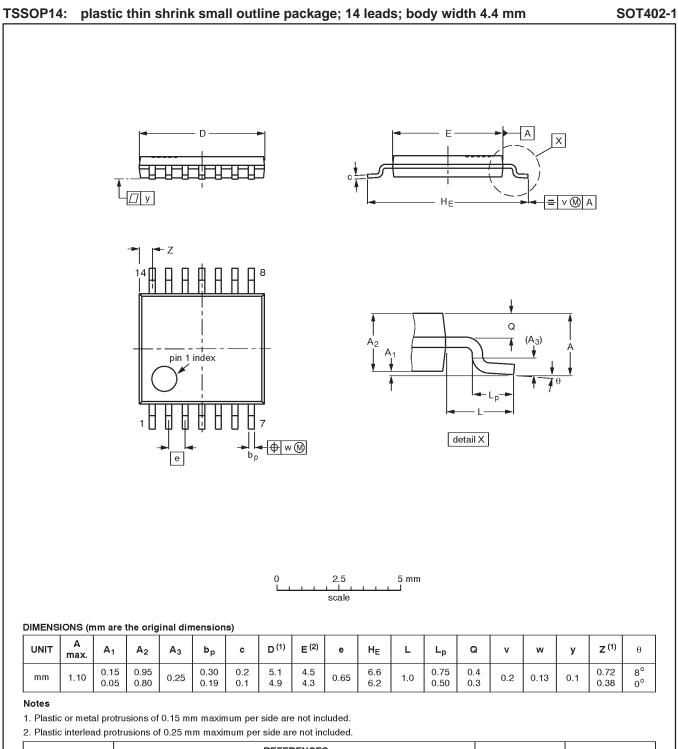


OUTLINE		REFERENCES				ISSUE DATE
VERSION	IEC	IEC JEDEC EIAJ PROJEC		PROJECTION	ISSUE DATE	
SOT108-1	076E06\$	MS-012AB				91-08-13- 95-01-23

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OUTLINE	REFERENCES EUROPEAN				ISSUE DATE	
VERSION	IEC	JEDEC	EIAJ		PROJECTION	1550E DATE
SOT402-1		MO-153				-94-07-12 95-04-04

74LVC00A

DEFINITIONS					
Data Sheet Identification Product Status		Definition			
Objective Specification	Formative or in Design	This data sheet contains the design target or goal specifications for product development. Specifications may change in any manner without notice.			
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